

TO-220FP

ultra narrow leads

D(2) $_{\bigcirc}$

ပ် S(3)

Figure 1: Internal schematic diagram

G(1) O

N-channel 600 V, 0.68 Ω typ., 10 A, SuperMESH™ Power MOSFET in a TO-220FP ultra narrow leads package

Datasheet - production data



Order code	VDS	RDS(on) max.	Iр	Ptot
STFU10NK60Z	600 V	0.75 Ω	10 A	35 W

- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Zener-protected

Applications

• Switching applications

Description

This high voltage device is a Zener-protected N-channel Power MOSFET developed using the SuperMESH™ technology by STMicroelectronics, an optimization of the well-established PowerMESH™. In addition to a significant reduction in on-resistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

Table 1: Device summary

SC15010

Order code	Marking	Package	Packaging
STFU10NK60Z	10NK60Z	TO-220FP ultra narrow leads	Tube

December 2016

DocID028779 Rev 3

This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
VDS	Drain-source voltage	600	V
V _{GS}	Gate-source voltage	±30	V
I _D ⁽¹⁾	Drain current (continuous) at Tc= 25 °C	10	А
ID ⁽¹⁾	Drain current (continuous) at T _c = 100 °C	5.7	А
I _{DM} ⁽²⁾	Drain current (pulsed)	36	А
Ртот	Total dissipation at $T_c = 25 \ ^{\circ}C$	35	W
ESD	Gate-source, human body model (R = $1.5 \text{ k}\Omega$, C = 100 pF)	4	kV
dv/dt ⁽³⁾	Peak diode recovery voltage slope	4.5	V/ns
Viso	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1s; T_c = 25 °C)	2500	V
Tj	Operation junction temperature range	55 to 150	°C
T _{stg}	Storage temperature range	-55 to 150	

Notes:

⁽¹⁾Limited by package

 $^{(2)}\mbox{Pulse}$ width limited by safe operating area

 $^{(3)}I_{SD}$ < 10 A , di/dt < 200 A/µs , V_DD = 80 % V_{(BR)DSS}

Table 3: Thermal data

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	3.6	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or non-repetitive (pulse width limited by T_J max)	10	А
E _{AS}	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)	300	mJ



2 Electrical characteristics

(T_c = 25 °C unless otherwise specified)

	_			_		
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS}=0~V,~I_D=250~\mu A$	600			V
I _{DSS} Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 600 V$			1	μA	
	c c				50	μA
I _{GSS}	Gate-body leakage current	V_{DS} = 0 V, V_{GS} = +20 V			±10	μΑ
VGS(th)	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	3	3.75	4.5	V
RDS(on)	Static drain-source on- resistance	V_{GS} = 10 V, I_{D} = 4.5 A		0.68	0.75	Ω

Table 5: On /off states

Notes:

 $\ensuremath{^{(1)}}\xspace$ Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	1370	-	pF
Coss	Output capacitance	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz	-	156	-	pF
Crss	Reverse transfer capacitance		-	37	-	pF
Coss eq ⁽¹⁾	Equivalent output capacitance	V_{GS} = 0 V, V_{DS} = 0 to 480 V	-	93	-	pF
Qg	Total gate charge	$V_{DD} = 480 \text{ V}, \text{ I}_{D} = 8 \text{ A},$	-	48	-	nC
Qgs	Gate-source charge	$V_{GS} = 10 V$	-	8	-	nC
Q _{gd}	Gate-drain charge	(see Figure 13: "Test circuit for gate charge behavior")	-	25	-	nC

Table 6: Dynamic

Notes:

 $^{(1)}C_{oss\ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80%

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 4 \text{ A},$	-	20	-	ns
tr	Rise time	$R_G = 4.7 \ \Omega, V_{GS} = 10 \ V$	-	20	-	ns
t _{d(off)}	Turn-off delay time	(see Figure 12: "Test circuit for resistive load switching	-	55	-	ns
t _f	Fall time	times" and Figure 17: "Switching time waveform")	-	30	-	ns



Electrical characteristics

_	Table 8: Source drain diode							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
I _{SD} ⁽¹⁾	Source-drain current		-		10	V		
I _{SDM} ⁽²⁾	Source-drain current (pulsed)		-		36	А		
Vsd ⁽³⁾	Forward on voltage	I _{SD} = 10 A, V _{GS} = 0 V	-		1.6	V		
trr	Reverse recovery time	I _{SD} = 8 A, di/dt = 100 A/µs,	-	570		ns		
Qrr	Reverse recovery charge	$V_{DD} = 40 \text{ V}$, $T_J = 150 \text{ °C}$	-	4.1		μC		
Irrm	Reverse recovery current	(see Figure 14: "Test circuit for inductive load switching and diode recovery times")	-	15		A		

Notes:

⁽¹⁾Limited by package

⁽²⁾Pulse width limited by safe operating area

 $^{(3)}\text{Pulsed:}$ pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

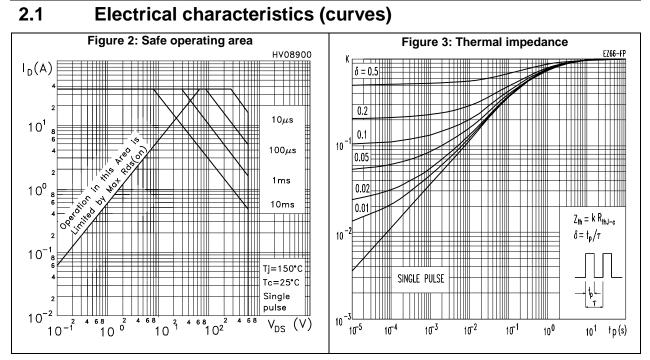
Table 9: Gate-source Zener diode

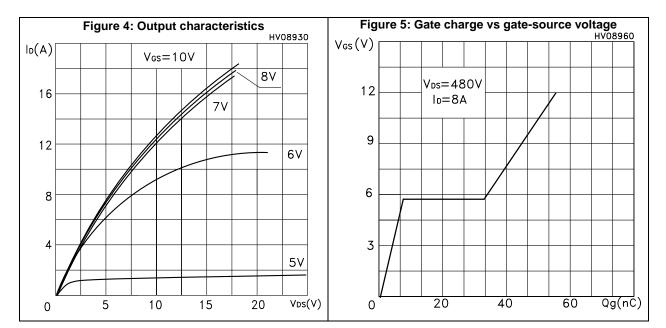
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.





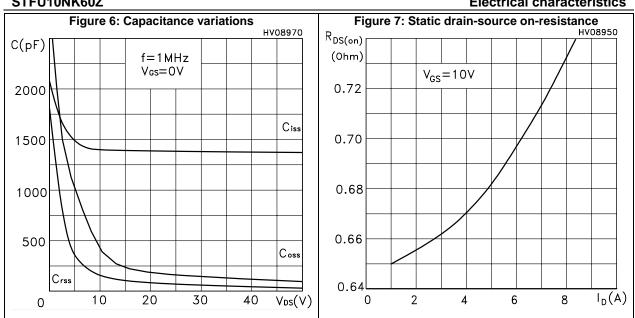


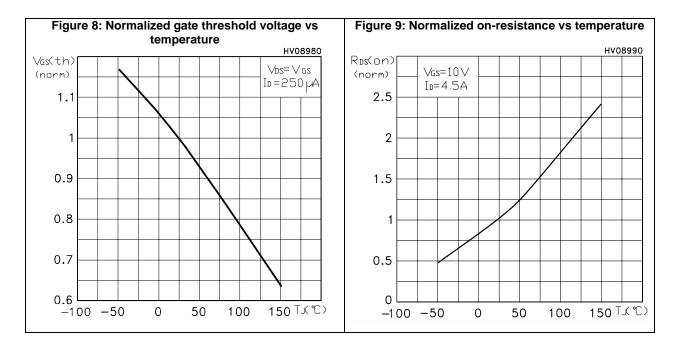


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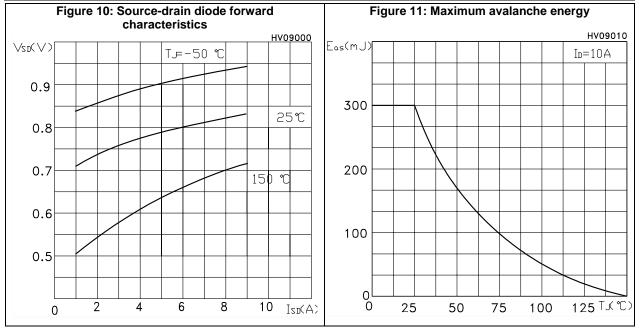
Electrical characteristics





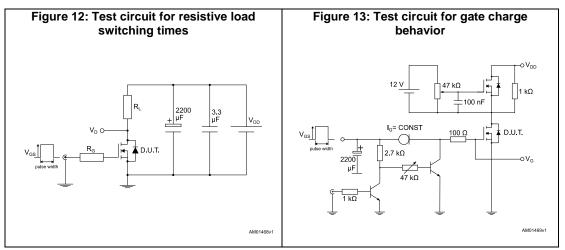
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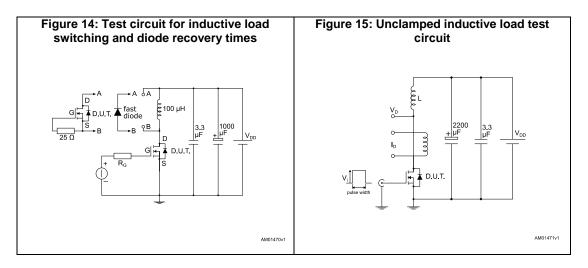


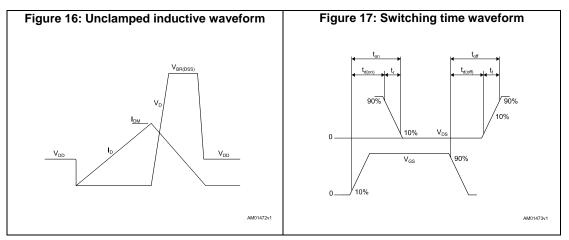




3 Test circuits







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4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

4.1 TO-220FP ultra narrow leads package information

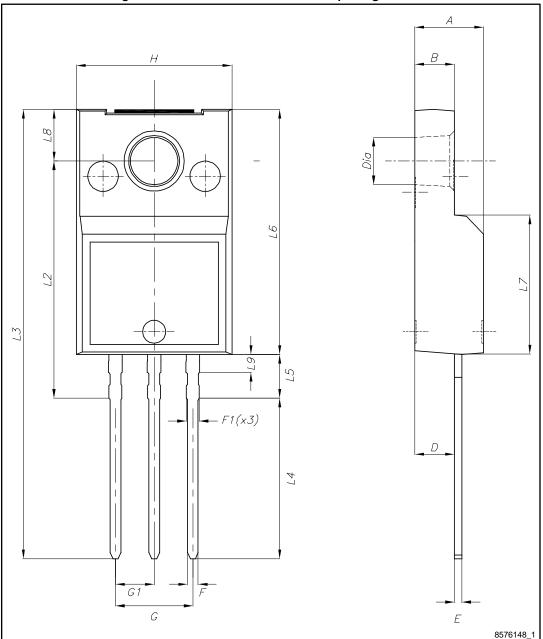


Figure 18: TO-220FP ultra narrow leads package outline





Package information

Table 10: TO-220FP ultra narrow leads mechanical data			
Dim.	mm		
	Min.	Тур.	Max.
A	4.40		4.60
В	2.50		2.70
D	2.50		2.75
E	0.45		0.60
F	0.65		0.75
F1	-		0.90
G	4.95		5.20
G1	2.40	2.54	2.70
н	10.00		10.40
L2	15.10		15.90
L3	28.50		30.50
L4	10.20		11.00
L5	2.50		3.10
L6	15.60		16.40
L7	9.00		9.30
L8	3.20		3.60
L9	-		1.30
Dia.	3.00		3.20



5 Revision history

Table 11: Document revision history

Date	Revision	Changes	
07-Jan-2016	1	Initial release.	
12-Sep-2016	2	Document status changed from preliminary to production data. Minor text changes.	
05-Dec-2016	3	Updated Features on cover page. Updated Table 2: "Absolute maximum ratings" and added Table 4: "Avalanche characteristics". Updated Table 5: "On /off states", Table 6: "Dynamic", Table 8: "Source drain diode" and Table 9: "Gate-source Zener diode". Minor text changes	



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